

BFW 68

HIGH FREQUENCY AMPLIFIER

NPN DIFFUSED SILICON PLANAR EPITAXIAL TRANSISTOR

GENERAL DESCRIPTION - The BFW68 is an NPN Diffused Silicon Planar Transistor which has been designed for high frequency amplifier and oscillator applications.

ABSOLUTE MAXIMUM RATINGS (Note 1)

Maximum Temperatures

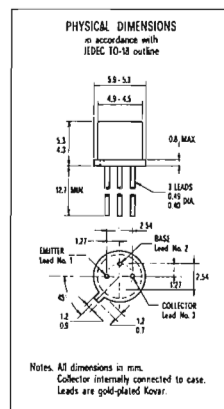
T_{STG}	Storage Temperature Range	-55°C to 200°C
T_J	Operating Junction Temperature	200°C
T_L	Lead Temperature (Soldering, 10 s time limit)	260°C

Maximum Power Dissipations (Notes 2 and 3)

P_D	Total Dissipation at 25°C Case Temperature	1.2 W
	at 25°C Ambient Temperature	0.36 W

Maximum Voltages (25°C free air temperature)

V_{CBO}	Collector to Base Voltage	50 V
V_{CEO}	Collector to Emitter Voltage (Note 4)	40 V
V_{EBO}	Emitter to Base Voltage	5 V



ELECTRICAL CHARACTERISTICS (25°C free air temperature unless otherwise noted)

SYMBOL	CHARACTERISTIC	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
h_{FE}	DC Current Gain (Note 5)	35	80			$I_C = 100 \mu A$ $V_{CE} = 10 V$
h_{FE}	DC Current Gain (Note 5)	45	120			$I_C = 1 mA$ $V_{CE} = 10 V$
h_{FE}	DC Current Gain (Note 5)	50	120			$I_C = 10 mA$ $V_{CE} = 1 V$
h_{FE}	DC Current Gain (Note 5)	40	105			$I_C = 50 mA$ $V_{CE} = 10 V$
V_{BEsat}	Base Saturation Voltage (Note 5)	0.75	0.85		V	$I_C = 10 mA$ $I_B = 1 mA$
V_{BEsat}	Base Saturation Voltage (Note 5)	0.86	1		V	$I_C = 50 mA$ $I_B = 5 mA$
V_{CEsat}	Collector Saturation Voltage (Note 5)	0.09	0.15		V	$I_C = 10 mA$ $I_B = 1 mA$
V_{CEsat}	Collector Saturation Voltage (Note 5)	0.2	0.4		V	$I_C = 50 mA$ $I_B = 5 mA$
I_{CBO}	Collector Reverse Current	0.1	10		nA	$V_{CB} = 30 V$ $I_E = 0$
$I_{CBO} (125^\circ C)$	Collector Reverse Current	0.1	30		μA	$V_{CB} = 30 V$ $I_E = 0$
BV_{CBO}	Collector to Base Breakdown Voltage	50			V	$I_C = 10 \mu A$ $I_E = 0$
BV_{EBO}	Emitter to Base Breakdown Voltage	5			V	$I_E = 10 \mu A$ $I_C = 0$
V_{CEO}	Collector to Emitter Sustaining Voltage (Notes 4 and 5)	40			V	$I_C = 10 mA$ $I_B = 0$

ELECTRICAL CHARACTERISTICS (25°C free air temperature unless otherwise noted)

SYMBOL	CHARACTERISTIC	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
h_{fe}	Small Signal Current Gain.....	40.....	200.....			$I_C = 1 \text{ mA}$ $V_{CE} = 5 \text{ V}$ $f = 1 \text{ kHz}$
h_{ie}	Input Resistance.....		6.....		$k\Omega$	$I_C = 1 \text{ mA}$ $V_{CE} = 5 \text{ V}$ $f = 1 \text{ kHz}$
h_{oe}	Output Conductance.....		75.....		μmho	$I_C = 1 \text{ mA}$ $V_{CE} = 5 \text{ V}$ $f = 1 \text{ kHz}$
h_{re}	Voltage Feedback Ratio.....		5.....		$\times 10^{-4}$	$I_C = 1 \text{ mA}$ $V_{CE} = 5 \text{ V}$ $f = 1 \text{ kHz}$
h_{fe}	High Frequency Current Gain.....	2.5.....	4.....			$I_C = 10 \text{ mA}$ $V_{CE} = 15 \text{ V}$ $f = 100 \text{ MHz}$
C_{TE}	Emitter Transition Capacitance.....	6.....	10.....		pF	$I_C = 0$ $V_{EB} = 0.5 \text{ V}$
C_{obo}	Base-Collector Capacitance.....	3.....	4.....		pF	$I_E = 0$ $V_{CB} = 10 \text{ V}$
NF	Noise Figure.....	5.8.....			dB	$I_C = 1 \text{ mA}$ $f = 100 \text{ MHz}$ $R_S = 200 \Omega$ $V_{CE} = 5 \text{ V}$ $f = 1 \text{ kHz}$
h_{fe}	Small Signal Current Gain.....	50.....	200.....			$I_C = 5 \text{ mA}$ $V_{CE} = 5 \text{ V}$ $f = 1 \text{ kHz}$
h_{ie}	Input Resistance.....		2.....		$k\Omega$	$I_C = 5 \text{ mA}$ $V_{CE} = 5 \text{ V}$ $f = 1 \text{ kHz}$
h_{oe}	Output Conductance.....		125.....		μmho	$I_C = 5 \text{ mA}$ $V_{CE} = 5 \text{ V}$ $f = 1 \text{ kHz}$
h_{re}	Voltage Feedback Ratio.....		5.....		$\times 10^{-4}$	$I_C = 5 \text{ mA}$ $V_{CE} = 5 \text{ V}$ $f = 1 \text{ kHz}$
t_{on}	Turn On Time.....	30.....			ns	$I_C = 50 \text{ mA}$ $I_{B1} = 5 \text{ mA}$
t_{off}	Turn Off Time.....	240.....			ns	$I_C = 50 \text{ mA}$ $I_{B1} = I_{B2} = 5 \text{ mA}$

NOTES:

- (1) These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
- (2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
- (3) These ratings give a maximum junction temperature of 200°C and junction-to-case thermal resistance of 146°C/W (derating factor of 6.9 mW/°C); junction-to-ambient thermal resistance of 486°C/W (derating factor of 2.06 mW/°C).
- (4) This rating refers to a high-current point where collector-to-emitter voltage is lowest. For more information send for SGS-AR 5.
- (5) Measured under pulse conditions: pulse length = 300 μsec ; duty cycle = 1%.